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CAPACITORS, FIXED, CHIPS, CERAMIC DIELECTRIC, TYPE I WITH FLEXIBLE TERMINATIONS

BASED ON TYPES 0603 TO 2220

ESCC Detail Specification No. 3009/040

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1 GENERAL

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for Capacitors, Fixed, Chips, Ceramic Dielectric, Type I With Flexible Terminations, based on Types 0603 to 2220. It shall be read in conjunction with ESCC Generic Specification No. 3009, the requirements of which are supplemented herein.

1.2 <u>COMPONENT TYPE VARIANTS AND RANGE OF COMPONENTS</u>

The variants and the range of components covered by this specification are given in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the components specified herein, are as scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION (FIGURE 1)

Not applicable.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the capacitors specified herein are shown in Figure 2.

1.6 <u>FUNCTIONAL DIAGRAM</u>

The functional diagram for the capacitors specified herein is shown in Figure 3.

2 APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:

(a) ESCC Generic Specification No. 3009, Capacitors, Fixed, Chips, Ceramic Dielectric, Types I and II

3 TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic specification No. 21300 shall apply.



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TABLE 1(a) - COMPONENT TYPE VARIANTS AND RANGE OF COMPONENTS

Variant Number	Style	Capacitance Range,	Terminal Mate	rial and Finish	Weight Max
		Tolerance, Rated Voltage	End Terminations	Termination Finish	(g)
01	0603	See Note 1	Flexible + Ni barrier	Sn/Pb coating (Note 2)	0.1
02	0805	See Note 1	Flexible + Ni barrier	Sn/Pb coating (Note 2)	0.1
03	1206	See Note 1	Flexible + Ni barrier	Sn/Pb coating (Note 2)	0.15
04	1210	See Note 1	Flexible + Ni barrier	Sn/Pb coating (Note 2)	0.15
05	1812	See Note 1	Flexible + Ni barrier	Sn/Pb coating (Note 2)	0.2
06	2220	See Note 1	Flexible + Ni barrier	Sn/Pb coating (Note 2)	0.3
07	0603	See Note 1	Flexible + Ni barrier	Au plating	0.1
08	0805	See Note 1	Flexible + Ni barrier	Au plating	0.1
09	1206	See Note 1	Flexible + Ni barrier	Au plating	0.15
10	1210	See Note 1	Flexible + Ni barrier	Au plating	0.15
11	1812	See Note 1	Flexible + Ni barrier	Au plating	0.2
12	2220	See Note 1	Flexible + Ni barrier	Au plating	0.3



NOTES:

1. Available rated voltages, capacitance values and tolerances are as follows:

Variant Number	Style		e Range C _n F)	Rated Voltage U _R
		Min Max		(V)
01, 07	0603	1	330	100
02, 08	0805	1	1200	
03, 09	1206	1	3900	
04, 10	1210	10	6800	
05, 11	1812	100	12000	
06, 12	2220	470	27000	
01, 07	0603	1	560	50
02, 08	0805	1	1800	
03, 09	1206	1	5600	
04, 10	1210	10	12000	
05, 11	1812	100	22000	
06, 12	2220	470	47000	
01, 07	0603	10	680	25
02, 08	0805	10	2200	
03, 09	1206	10	5600	
04, 10	1210	10	12000	
05, 11	1812	100	27000	
06, 12	2220	470	56000	
01, 07	0603	10	1000	16
02, 08	0805	10	2700	
03, 09	1206	10	6800	
04, 10	1210	10	15000	
05, 11	1812	100	33000	
06, 12	2220	470	68000	

Capacitance Value (pF)	Tolerance (±)	Value Series
For C _n ≤ 11.5pF	0.25pF	E 48
For C _n ≤ 9.1pF	0.5pF	E 24
For $C_n \le 8.2pF$	1pF	E 12
For C _n ≥ 27.4pF	1%	E 96
For C _n ≥ 12.7pF	2%	E 48
For C _n ≥ 10pF	5%	E 24
For C _n ≥ 10pF	10%	E 12

2. Sn/Pb coating, with typically 60% Sn 40% Pb.



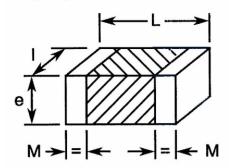
TABLE 1(b) - MAXIMUM RATINGS

Characteristics	Symbols	Maximum Ratings	Units	Remarks
Rated Voltage	U _R	16, 25, 50, 100	V	Note 1
Operating Temperature Range	T _{op}	-55 to +125	°C	Without derating. T _{amb}
Storage Temperature Range	T _{stg}	-55 to +125	°C	
Soldering Temperature	T _{sol}	+260	°C	Note 2

NOTES:

- As required; See Table 1(a). Duration 10 seconds maximum.

FIGURE 2 – PHYSICAL DIMENSIONS



Symbols		Dimensions (mm)										
	Style	0603	Style	0805	Style 1206 Style 1210		Style 1812		Style 2220			
	Variants	s 01, 07	Variants	s 02, 08	Variants	s 03, 09	Variants	s 04, 10	Variant	s 05, 11	Variants	s 06, 12
	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max
L	1.45	1.75	1.7	2.3	2.95	3.45	2.8	3.6	4	5	5.2	6.2
I	0.65	0.95	1.05	1.45	1.45	1.75	2.2	2.8	2.8	3.6	4.5	5.5
е	-	1	-	1.3	-	1.6	-	1.8	-	1.8	-	1.8
М	0.1	0.5	0.1	0.75	0.2	0.75	0.2	1	0.2	1	0.2	1

FIGURE 3 – FUNCTIONAL DIAGRAM



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4 **REQUIREMENTS**

4.1 GENERAL

The complete requirements for procurement of the components specified herein shall be as stated in this specification and ESCC Generic Specification No. 3009. Deviations from the Generic Specification, applicable to this specification only, are listed in Para 4.2.

Deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 <u>DEVIATIONS FROM GENERIC SPECIFICATION</u>

4.2.1 <u>Deviations from Special In-Process Controls</u>

None.

4.2.2 Deviations from Final Production Tests (Chart II)

None.

4.2.3 <u>Deviations from Burn-in and Electrical Measurements (Chart III)</u>

None.

4.2.4 <u>Deviations from Qualification Tests (Chart IV)</u>

None.

4.2.5 Deviations from Lot Acceptance Tests (Chart V)

None.

4.3 <u>MECHANICAL REQUIREMENTS</u>

4.3.1 <u>Dimension Check</u>

The dimensions of the components specified herein shall be verified in accordance with the requirements set out in Para. 9.3 of ESCC Generic Specification No. 3009 and shall conform to those shown in Figure 2 of this specification.

4.3.2 Weight

The maximum weight of the components specified herein shall be as given in Table 1(a).

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the capacitors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 Terminal Material and Finish

The terminal material and finish shall be as specified in Table 1(a).



4.5 MARKING

4.5.1 General

The marking shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and as follows.

The information to be marked on the component shall be:

- The ESCC qualified components symbol (for ESCC qualified components only).
- The ESCC Component Number. (b)
- (c) Traceability information.

4.5.2 **ESCC Component Number**

The ESCC Component Number shall be constituted and marked as follows:

Example: 3009xxx01B1000KC

- Detail Specification Reference: 3009xxx
- Component Type Variant Number: 01 (as required)
- Testing Level (B or C, as applicable): B
- Characteristic code: Capacitance Value (100pF): 1000 (as required)
- Characteristic code: Capacitance Tolerance (±5%): K (as required)
- Rating code: Rated Voltage (50V): C (as required)

4.5.2.1 Capacitance Value

Rated Capacitance Value C_n expressed by means of the following codes in accordance with ESCC Basic Specification No. 21700. The unit quantity shall be picofarad (pF).

Capacitance Value C _n	Code
(pF)	
X.XX	XCXX
XX.X	XXCX
XXX	XXX0
XXX 10 ¹	XXX1
XXX 10 ²	XXX2

4.5.2.2 Tolerance

Capacitance Tolerance expressed by the following codes in accordance with ESCC Basic Specification No. 21700:

Tolerance (±)	Code Letter	Remark
0.25pF	С	
0.5pF	D	
1pF	F	For $C_n \le 8.2pF$
1%	F	For $C_n \ge 27.4pF$
2%	G	
5%	J	
10%	K	

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4.5.2.3 Rated Voltage

Rated Voltage expressed by the following codes:

Rated Voltage	Code Letter
(V)	
16	X
25	A
50	С
100	E

4.5.3 Traceability Information

Traceability information shall be marked in accordance with the requirements of ESCC Basic Specification No. 21700.

4.6 <u>ELECTRICAL MEASUREMENTS</u>

4.6.1 <u>Electrical Measurements at Room Temperature</u>

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified the measurements shall be performed at $T_{amb} = +22 \pm 3^{\circ}C$.

4.6.2 <u>Electrical Measurements at High and Low Temperatures</u>

The parameters to be measured at high and low temperatures are scheduled in Table 3. The measurements shall be performed at the respective temperatures defined in Table 3.

4.6.3 <u>Circuits for Electrical Measurements (Figure 4)</u>

Not applicable.

4.7 BURN-IN TESTS

4.7.1 <u>Parameter Drift Values</u>

The parameter drift values applicable to Burn-in are as specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

The parameter drift values (Δ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit values specified in Table 2 shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for Burn-in are specified in Section 7 of ESCC Generic Specification No. 3009. The conditions for Burn-in shall be as specified in Table 5 of this specification.

After Burn-in, the components shall be removed from the chamber and allowed to cool under normal atmospheric conditions for recovery for 24 hours minimum.

4.7.3 Electrical Circuit for Burn-in (Figure 5)

Not applicable.

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TABLE 2 – ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE

Characteristics	Symbols	Test Method and	Tolerance	Lin	Units	
		Conditions	(±)	Min Max		
Capacitance	C _A	ESCC No. 3009				pF
		Para. 9.4.1.1	0.25pF	C_{n} -0.25	$C_n + 0.25$	
			0.5pF	C_{n} -0.5	C _n +0.5	
			1pF	C _n -1	C _n +1	
			1%	$0.99C_n$	1.01C _n	
			2%	$0.98C_n$	1.02C _n	
			5%	$0.95C_n$	1.05C _n	
			10%	0.9C _n	1.1C _n	
Tangent of	tgδ	ESCC No. 3009	All			
Loss Angle		Para. 9.4.1.2				
		For $C_n < 50pF$		-	Note 1	
		For $C_n > 50pF$		-	15 x10 ⁻⁴	-
Insulation	Rı	ESCC No. 3009	All			
Resistance		Para. 9.4.1.3				
		For $C_n \le 10000pF$		100	-	GΩ
		For $C_n > 10000pF$		1000	-	MΩ.μF
Voltage Proof	VP	ESCC No. 3009	All	2.5U _R	-	V
		Para. 9.4.1.4				

NOTES:

1. For $C_n < 50$ pF, $tg\delta < 1.5 \times (150/C_n + 7) \times 10^{-4}$, where the unit quantity for C_n is in pF.

TABLE 3 – ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

Characteristics	Symbols	Test Method and	Limits		Units	Remarks	
		Conditions	Min	Max			
Insulation Resistance	R _I	ESCC No. 3009 Para. 9.4.1.3 T _{amb} = +125 ±3°C				Notes 1 and 2	
		For $C_n \le 10000pF$	10	-	GΩ		
		For C _n > 10000pF	100	-	MΩ.μF		
Temperature Coefficient	TC	ESCC No. 3009 Para. 9.11 T _{amb} between: -55°C and +20 ±2°C	-30	+30	10 ⁻⁶ /°C	5 parts for each capacitance value Notes 2, 4 and 5	
		+20 ±2°C and +125°C	-30	+30			
Temperature Coefficient	TC	ESCC No. 3009 Para. 9.11 T _{amb} between: +20 ±2°C and +125°C	-30	+30	10 ⁻⁶ /°C	5 parts for each dielectric lot Notes 3, 4 and 5	

NOTES:

- 1. Single sample; Inspection Level S3; AQL = 2.5%
- 2. Applicable to Testing Level B only.
- 3. Applicable to Testing Level C only.
- 4. Temperature Coefficient is not specified for $C_n \le 20pF$ due to test equipment limitations.
- 5. In the event of any failure a 100% inspection may be performed. In the case of a 100% inspection, a 1% total percent defective is allowed.

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TABLE 4 – PARAMETER DRIFT VALUES

Characteristics	Symbols	Test Method and	Change Limits (∆)	Unit
		Conditions		
Capacitance Change	$\Delta C_A/C_A$	ESCC No. 3009	±0.5	pF
		Paras. 9.4.1.1 &	or (Note 1)	
		9.4.2	±1	%

NOTES:

Whichever is greater.

TABLE 5 – CONDITIONS FOR BURN-IN AND OPERATING LIFE TESTS

Characteristics	Symbols	Conditions	Units
Ambient Temperature	T _{amb}	+125 (+0 -5)	°C
Test Voltage	V_{T}	$2U_R$	V

4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESCC GENERIC</u> SPECIFICATION No. 3009)

4.8.1 <u>Measurements and Inspections on Completion of Environmental Tests</u>

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3^{\circ}C$.

4.8.2 Measurements and Inspections at Intermediate Points During Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3^{\circ}C$.

4.8.3 <u>Measurements and Inspections on Completion of Endurance Tests</u>

The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.4 <u>Conditions for Operating Life (Part of Endurance Testing)</u>

The requirements for Operating Life testing are specified in Section 9 of ESCC Generic Specification No. 3009. The conditions for Operating Life testing shall be as specified in Table 5 of this specification.

4.8.5 <u>Electrical Circuit for Operating Life Tests (Figure 5)</u> Not applicable.



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TABLE 6 – MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

Test Method				Limits		Unit
and	Identification	Conditions		Min	Max	
	Final Evenination					
Para 9.15	Terminals	Good Tinning	-	-	-	
	Final Measurements					
	Capacitance	Table 2	C_A	Record	d Values	
	Tangent of Loss Angle	Table 2	tgδ	No	Note 2	
	Insulation Resistance	Table 2	Rı	No		
Para. 9.5	Final Examination					
	Visual Examination	Damage or loosening	-	-	-	
	Capacitance	Table 2	C_A	No	Note 2	
Para. 9.6	Final Examination					
	Visual Examination	Para. 9.6.2	-	-	-	
Para. 9.7.2	Initial Measurements					
	Capacitance	Table 2	C_A	Note 3		
	Final Measurements	Recovery period 24 ±2 hours				
	Visual Examination	No damage	-	-	-	
	Capacitance Change	Table 2	$\Delta C_{\text{A}}\!/C_{\text{A}}$	-1	+1	pF or
				-1	+1	% (Note 4)
	Tangent of Loss Angle	Table 2	tgδ	-	Note 5	
Para. 9.8	Initial Measurements			Note 3		
	Capacitance	Table 2	C_A			
	Final Measurements	Recovery period 1 to 24 hours				
	Visual Examination	Para. 9.8.6	-	-	-	
	Capacitance Change	Table 2	$\Delta C_{\text{A}}\!/C_{\text{A}}$	-1	+1	pF or
				-2	+2	% (Note 4)
	Tangent of Loss Angle	Table 2	tgδ	-	Note 5	
	Insulation Resistance	Table 2				
		For $C_n \le 10000 pF$	R _i	10 100	-	GΩ MΩ.μF
	Para. 9.5 Para. 9.6 Para. 9.7.2	Para 9.15 Para 9.15 Final Examination Terminals Final Measurements Capacitance Tangent of Loss Angle Insulation Resistance Para. 9.5 Final Examination Visual Examination Capacitance Final Measurements Capacitance Change Para. 9.8 Initial Measurements Capacitance Change Final Measurements Capacitance Final Measurements Visual Examination Capacitance Change	Para 9.15 Para 9.15 Pinal Examination Terminals Final Measurements Capacitance Table 2 Tangent of Loss Angle Insulation Resistance Para. 9.5 Para. 9.5 Para. 9.6 Para. 9.7.2 Para. 9.7.2 Para. 9.7.2 Para. 9.7.2 Para. 9.7.2 Para. 9.7.2 Pinal Examination Visual Examination Capacitance Para. 9.7.2 Para. 9.7.2 Para. 9.7.2 Para. 9.7.2 Pinal Measurements Capacitance Change Para. 9.8 Para. 9.8 Para. 9.8 Para. 9.8 Initial Measurements Capacitance Para. 9.8 Table 2 Para. 9.8 Table 2 Final Measurements Capacitance Table 2 Para. 9.8 Table 2 Final Measurements Capacitance Table 2 Final Measurements Table 2 Final Measurements Table 2 Final Measurements Table 2 Table 2 Tangent of Loss Angle Insulation Resistance Table 2	Conditions Final Examination Terminals Good Tinning - Final Measurements Capacitance Insulation Resistance Insulation Insulation Resistance Insulation Insulation Resistance Insulation Resistance Insulation Insulation Resistance Insulation Insulation Resistance Insulation Insulation Resistance Insulation I	Conditions Final Examination Terminals Good Tinning - - Final Measurements Capacitance Tangent of Loss Angle Insulation Resistance Table 2 tgδ No	Conditions Final Examination Terminals Good Tinning - - - Final Measurements Capacitance Table 2 tgδ CA Record Values Note 2 Para. 9.5 Final Examination Visual Examination Visual Examination Visual Examination Visual Examination Damage or loosening Table 2 CA Note 2 CA Note 2 Para. 9.6.2 Final Examination Visual Examination Visual Examination Visual Examination Visual Examination Visual Examination Visual Examination Capacitance Table 2 CA Note 3 Note 3 Para. 9.7.2 Initial Measurements Visual Examination Capacitance Change Recovery period 24 ±2 hours No damage





ESCC Generic Spec. No. 3009 Measurements and Inspections Symbol Limits Unit Test Method Environmental Identification Conditions Min Max and Endurance and Conditions Tests (Note 1) Damp Heat **Initial Measurements** Para. 9.9 Steady State Capacitance Table 2 C_A Note 3 **Final Measurements** Recovery period 6 to 24 ±2 hours Visual Examination No damage Capacitance Change Table 2 $\Delta C_A/C_A$ -1 +1 pF or -2 % +2 (Note 4) Table 2 Tangent of Loss Angle tgδ Note 5 Insulation Resistance Table 2 For $C_n \le 10000pF$ 10 GΩ R_{l} 100 MΩ.μF For $C_n > 10000pF$ R_{l} Para. 9.10 **Initial Measurements** Operating Life Note 3 Capacitance Table 2 C_A Intermediate Recovery period Measurements 1 hour minimum To be performed at 1000 hours (Chart IV) pF or Capacitance Change Table 2 $\Delta C_A/C_A$ -1 +1 -3 +3 % (Note 4) Insulation Resistance Table 2 For $C_n \le 10000pF$ R_{I} 10 GΩ For $C_n > 10000pF$ 100 $M\Omega.\mu F$ R_{I} **Final Measurements** Recovery period 24 ±2 hours Table 2 $\Delta C_A/C_A$ pF or Capacitance Change -1 +1 -3 +3 % (Note 4) Tangent of Loss Angle Table 2 Note 5 tgδ Insulation Resistance Table 2 For $C_n \le 10000pF$ GΩ R_{I} 10 For $C_n > 10000pF$ $M\Omega.\mu F$ R_{I} 100 VΡ Voltage Proof Table 2 Note 2 Visual Examination No damage

NOTES:

Temperature

Coefficient

- 1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.
- 2. As specified in Table 2.

Para. 9.11

Temperature

Coefficient

3. Capacitance values recorded during Mounting shall be used as initial measurements.

Table 3

TC

Note 6

- 4. Whichever is greater.
- 5. Twice the value specified in Table 2.
- 6. As specified in Table 3.